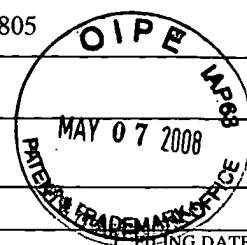


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INFORMATION DISCLOSURE STATEMENT

APPLICANT
Milton W. Demaray, et al.FILING DATE
September 29, 2003GROUP
2182

U.S. PATENT DOCUMENTS

*Exam. Initial	Cite No.	DOCUMENT NUMBER Number - Kind Code	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	FILING DATE
		US-			
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FOREIGN PATENT DOCUMENTS

*Exam. Initial	Cite No.	DOCUMENT NUMBER Number - Kind Code	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	TRANSLATION YES NO
		WO-2005/033941	4-14-2005	PCT	

NON-PATENT LITERATURE DOCUMENTS

*Exam. Initial	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	TRANSLATION YES NO
		WO-2005/033941 - International Search Report and Written Opinion of the International Searching Authority (cited references previously disclosed with Information Disclosure Statement filed on 02/14/06, consisting only of U.S. patents and published applications).	
		European Patent Office - 08/18/06 --Examination report for Appl. No. 04 784 444.4 -2224.	
		Applicant's 12/18/06 Response to European Patent Office — Examination report for Application No. 04 784 444.4 -2224 dated 08/18/06.	
		European Patent Office -01/23/07 -- Examination report for Application No. 04 784 444.4 -2224	
		Applicant's 05/23/07 Response to European Patent Office --Examination report for Application No. 04 784 444.4 -2224 dated 01/23/07.	
		European Patent Office - 07/19/07 Communication under Rule 51(4) EPC informing of intention to grant European patent.	

EXAMINER

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